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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/842,935	04/26/2001	Michael Kozhukh	INTL-0561-US (P11332)	1185	
75	590 08/26/2004		EXAMINER		
Timothy N. Trop TROP, PRUNER & HU, P.C.			CHANG, AUDREY Y		
STE 100	R & HU, P.C.		ART UNIT PAPER NUMBER		
8554 KATY FWY			2872		
HOUSTON, T	X 77024-1805		DATE MAILED: 08/26/2004	DATE MAILED: 08/26/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
	09/842,935	KOZHUKH, MICHAEL				
Office Action Summary	Examiner	Art Unit				
	Audrey Y. Chang	2872	KO			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence add	iress			
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period was preply in the set of extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	66(a). In no event, however, may a reply be tin within the statutory minimum of thirty (30) day ill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	nely filed vs will be considered timely. the mailing date of this cor CD (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 07 Ju	<u>ine 2004</u> .					
2a)⊠ This action is <b>FINAL</b> . 2b)☐ This	action is non-final.					
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the practice under E	x parte Quayle, 1935 C.D. 11, 4	53 O.G. 213.				
Disposition of Claims						
4)⊠ Claim(s) <u>1-3,8-11,13,16,17,23 and 24</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>1-3,8-11,13,16,17,23 and 24</u> is/are rejected.						
7) Claim(s) is/are objected to.						
8) Claim(s) are subject to restriction and/or	r election requirement.					
Application Papers						
9) The specification is objected to by the Examine	r.					
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to the	drawing(s) be held in abeyance. Se	e 37 CFR 1.85(a).				
Replacement drawing sheet(s) including the correct						
11) The oath or declaration is objected to by the Ex	aminer. Note the attached Office	Action or form PT	O-152.			
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a	)-(d) or (f).				
a) ☐ All b) ☐ Some * c) ☐ None of:						
1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No						
3. Copies of the certified copies of the priority documents have been received in this National Stage						
application from the International Bureau (PCT Rule 17.2(a)).						
* See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s)						
1) Notice of References Cited (PTO-892)	4) Interview Summary					
2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)	Paper No(s)/Mail D  5) Notice of Informal F		-152)			
Paper No(s)/Mail Date	6) Other:		,			
5. Patent and Trademark Office						

## **DETAILED ACTION**

### Remark

- This Office Action is in response to applicant's amendment filed on Jun 7, 2004, which has been entered into the file.
- By this amendment, the applicant has amended claims 8-9, and 16 and has canceled claims 25-30.
- Claims 1-3, 8-11, 13, 16-17 and 23-24 remain pending in this application.
- The objection to claim 9 set forth in the previous Office Action is withdrawn in response to the amendment.

# Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-3, and 16-17 are rejected under 35 U.S.C. 103(a) as being unpatentable over the patent issued to Li et al (PN. 5,619,059) in view of the patent issued to Oyama et al (PN. 6,572,990).

The reasons for rejection are set forth in the previous Office Action dated November 25, 2003.

They are stated as follows.

Li et al teaches a color deformable mirror device (10) having a plurality of electronically controlled micro-mirrors that each is comprised of a mirror element (16, Figure 1) with a color mirror (34). The color mirror (34) is comprised of a mirror substrate (22), which can be made of semiconductor material such as silicon, (please see column 6, lines 41-43), and an optical thin film interference color coating (24), serves as the absorbing layer, formed on top of the mirror substrate, wherein a high

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reflectance *silver layer* (26) is *directly* formed on top of the silicon mirror substrate as shown in Figure 1, (please see column 6, lines 44-50).

Li et al further teaches that the optical thin film interference color coating layer (24), having multilayer structure design, is capable of enhancing reflection and absorption of light incident upon the coating, (please see column 6, lines 15-40) and in particularly it includes absorbing layers (30 and 32, please see column 5, lines 49-51) and transparent layer (28) that can be formed by layer materials such as silicon dioxide and silicon nitride dielectric materials, (please see column 6, lines 55-58). The interference coating including the absorbing layers are formed over the silver layer such that the interference coating is designed to reflect red, blue or green color of light. It is implicitly true that the interference coating is also absorbing color of light that is not intended for reflection which implicitly including the absorption of blue light, (please see Figures 1 and 2, columns 5-6). The method of forming the color deformable mirror device is in implicitly included.

Claims 1 and 16 have been amended to include the feature to have the absorbing layer "selectively absorb" blue light. It is implicitly true that the selectively absorption is implied by the design of the filter.

This reference has met all the limitations of the claims with the exception that it does not teach explicitly that the layer thickness for the absorbing layer components in the interference coating is between 700 to 750 Angstroms. However Li et al does teach that by varying the thickness of the layers in the interference coating different reflection characteristics and implicitly different absorption characteristics, in order to obtain optimum performance, can be achieved, (please see column 6, lines 27-36). Furthermore, **Oyama** et al in the same field of endeavor teaches *an absorbing layer* that is comprised of a transparent nitride film, which includes *silicon nitride*, with a thickness ranged between 40 to 80 nm or 400 to 800 angstroms and an oxide film consisting essentially *silicon dioxide* film with a thickness of between 70 to 140 nm or 700 to 1400 angstroms, (column 4 lines 23-47, column 6 lines 36-

40). It would then have been obvious to one skilled in the art to apply the teachings of Oyama et al to modify the interference coating of Li et al to include the layer materials of silicon dioxide and silicon nitride with the thickness taught for the benefit of obtaining desired absorbing property for the interference coating.

With regard to claim 17, Li et al teaches that the color mirrors (34) in the deformable mirror device (DMD) are *micro-mirrors* that each can be switched on or off by driving electronics, (please see Figures 1-2).

3. Claims 8-10 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over the patent issued to Li et al in view of the patent issued to Iacovangelo et al (PN. 6,587,263).

The reasons for rejection are set forth in the previous Office Action dated November 25, 2003, which are stated as follows.

Li et al teaches a color deformable mirror device (10) having a plurality of electronically controlled micro-mirrors that each is comprised of a mirror element (16, Figure 1) with a color mirror (34). The color mirror (34) is comprised of a mirror substrate (22), which can be made of semiconductor material such as silicon, (please see column 6, lines 41-43), and an optical thin film interference color coating (24), serves as the absorbing layer, formed on top of the mirror substrate, wherein a high reflectance silver layer (26) is directly formed on top of the silicon mirror substrate as shown in Figure 1, (please see column 6, lines 44-50).

Li et al further teaches that the optical thin film interference color coating layer (24), having multilayer structure design, is capable of enhancing reflection and absorption of light incident upon the coating, (please see column 6, lines 15-40) and in particularly it includes absorbing layers (30 and 32, please see column 5, lines 49-51) and transparent layer (28) that can be formed by layer materials such as silicon dioxide and silicon nitride dielectric materials, (please see column 6, lines 55-58). The

interference coating including the absorbing layers are formed over the silver layer such that the interference coating is designed to reflect red, blue or green color of light. It is implicitly true that the interference coating is also absorbing color of light that is not intended for reflection which implicitly including the *absorption of blue light*, (please see Figures 1 and 2, columns 5-6). The method of forming the color deformable mirror device is in implicitly included.

Claim 8 has been amended to include the feature to have the absorbing layer "selectively absorb" blue light. It is implicitly true that the selectively absorption is implied by the design of the filter.

With regard to claims 10 and 13, Li et al teaches that the thin film interference coating (24), serves as the absorbing layer include two different insulator materials, (please see column 6, lines 41-62). It is understood in the art that an *interference* coating essentially comprises alternative material layers having different refractive indices. These materials layers are formed by *chemical vapor deposition method*, (please see column 9).

This reference however does not teach explicitly that the interference coating or the absorbing layer is formed at a temperature of less than 250° C. But chemical vapor deposition method is a extremely well known method in the art for forming thin film layer the temperature specifics are therefore either inherently included in the disclosure of Li et al or an obvious modification to one skilled in the art. Furthermore, **Iacovangelo** et al in the same field of endeavor teach a thin film layer includes silicon oxide and silicon nitride layer can be deposited using chemical vapor deposition method at a temperature of less than 250° C, (please see column 4, liens 51-56 and table B). It would then have been obvious to one skilled in the art to modify the deposition method to make the deposition at a temperature of less than 250° C for the benefit of minimize thermal expansion mismatch problem.

4. Claim 11 is rejected under 35 U.S.C. 103(a) as being unpatentable over the patent issued to Li et al in view of the patent issued to Iacovangelo et al as applied to claim 8 above, and further in view of the patent issued to Kaitsu et al (PN. 5,774,783).

The color deformable mirror device taught by Li et al in combination with the teachings of lacovangelo et al as described for claim 8 above have met all the limitations of the claim with the exception that it does not teach explicitly that the reflective silver layer is deposited at 50 °C. However using low temperature deposition process to deposit silver layer on a silicon substrate is very well known in the art as demonstrated by the teachings of Kaitsu et al et al wherein a silver layer is sputtered on a silicon substrate at temperature about 20°C, (please see column 7, lines 34-40). It would then have been obvious to one skilled in the art to apply the teachings of Kaitsu et al to form the silver layer at temperature less than 50 °C for the benefit of providing a deposition process for depositing the silver layer at low temperature such as room temperature to reduce manufacturing cost.

5. Claim 23 is rejected under 35 U.S.C. 103(a) as being unpatentable over the patents issued to Li et al and Oyama et al as applied to claim 16 above, and further in view of the patent issued to Kaitsu et al.

The color deformable mirror device taught by Li et al in view of the teachings of Oyama et al as described for claim 16 above have met all the limitations of the claim with the exception that they do not teach explicitly that the silver layer is formed at a temperature below 50°C. However using low temperature deposition process to deposit silver layer on a silicon substrate is very well known in the art as demonstrated by the teachings of Kaitsu et al et al wherein a silver layer is sputtered on a silicon substrate at temperature about 20°C, (please see column 7, lines 34-40). It would then have been obvious to one skilled in the art to apply the teachings of Kaitsu et al to form the silver layer at

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temperature less than 50 °C for the benefit of providing a deposition process for depositing the silver layer at low temperature such as room temperature to reduce manufacturing cost.

6. Claim 24 is rejected under 35 U.S.C. 103(a) as being unpatentable over the patent issued to Li et al in view of the patent issued to Oyama et al as applied to claim 16 above, and further in view of the patent issued to Iacovangelo et al.

The reasons for rejection are set forth in the previous Office Action dated November 25, 2003, which stated as followed.

The color deformable mirror device taught by Li et al in view of the teachings of Oyama et al as described for claim 16 above have met all the limitations of the claim with the exception that they do not teach explicitly that the absorbing layer or the interference coating is formed at a temperature below 250° C. However chemical vapor deposition method is a extremely well known method in the art for forming thin film layer the temperature specifics are therefore either inherently included in the disclosure of Li et al or an obvious modification to one skilled in the art. Furthermore, Iacovangelo et al in the same field of endeavor teach thin film layers including silicon oxide and silicon nitride layer can be deposited using chemical vapor deposition method at a temperature of less than 250° C, (please see column 4, liens 51-56 and table B). It would then have been obvious to one skilled in the art to modify the deposition method to make the deposition at a temperature of less than 250° C for the benefit of minimize thermal expansion mismatch problem.

## Response to Arguments

7. Applicant should submit an argument under the heading "Remarks" pointing out disagreements with the examiner's contentions. Applicant must also discuss the references applied against the claims, explaining how the claims avoid the references or distinguish from them. No arguments to the rejections

have been submitted by the applicant. Arguments presented in the previous response have been fully addressed in the previous Office Actions.

### Conclusion

8. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Audrey Y. Chang whose telephone number is 571-272-2309. The examiner can normally be reached on Monday-Friday (8:00-4:30), alternative Mondays off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Drew Dunn can be reached on 571-272-2312. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Audrey Y. Chang Primary Examiner Art/Unit 2872

A. Chang, Ph.D.